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10/717,913 Examiner

David E. Bochna

Applicant(s)/Patent	under
Reexamination	

ICHIMURA ET AL.

Art Unit

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SEARCHED					
Class	Subclass	Date	Examiner		
285	3,82	9/10/2007	DB		
	202				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
288	382	9/10/2007	DB		
	203				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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